REVISIONS			
LTR	DESCRIPTION	DATE (YR-MO-DA)	APPROVED
A	Paragraph 1.3 corrected the Output current (I_{OUT}) from 2.0 A to 3.0 A. Updated drawing to reflect current requirements. -sld	02-08-27	Raymond Monnin
B	Update drawing. -gz	07-01-09	Joseph Rodenbeck
C	Updated drawing paragraphs. -sld	12-05-15	Charles F. Saffle

REV																				
SHEET																				
REV																				
SHEET																				

REV STATUS	REV	C	C	C	C	C	C	C	C	C	C				
OF SHEETS	SHEET	1	2	3	4	5	6	7	8	9	10				

PMIC N/A

STANDARD MICROCIRCUIT DRAWING

THIS DRAWING IS AVAILABLE FOR USE BY ALL DEPARTMENTS AND AGENCIES OF THE DEPARTMENT OF DEFENSE

AMSC N/A

PREPARED BY
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CHECKED BY
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APPROVED BY
Kendall A. Cottongim

DRAWING APPROVAL DATE
99-07-06

REVISION LEVEL
C

DLA LAND AND MARITIME
COLUMBUS, OHIO 43218-3990
http://www.landandmaritime.dla.mil/

MICROCIRCUIT, LINEAR, VOLTAGE REGULATOR, POSITIVE, ADJUSTABLE, LOW DROPOUT, MONOLITHIC SILICON

SIZE	CAGE CODE	
A	**67268**	**5962-98649**

SHEET 1 OF 10

1. SCOPE

1.1 Scope. This drawing documents five product assurance classes as defined in paragraph 1.2.3 and MIL-PRF-38534. A choice of case outlines and lead finishes which are available and are reflected in the Part or Identifying Number (PIN). When available, a choice of radiation hardness assurance levels are reflected in the PIN.

1.2 PIN. The PIN shall be as shown in the following example:

5962	-	98649	01	H	T	X
½	½		½	½	½	½
½	½		½	½	½	½
½	½		½	½	½	½
Federal stock class designator	RHA designator (see 1.2.1)		Device type (see 1.2.2)	Device class designator (see 1.2.3)	Case outline (see 1.2.4)	Lead finish (see 1.2.5)
_____	_____	_____/				
	\/					
	Drawing number					

1.2.1 Radiation hardness assurance (RHA) designator. RHA marked devices shall meet the MIL-PRF-38534 specified RHA levels and shall be marked with the appropriate RHA designator. A dash (-) indicates a non-RHA device.

1.2.2 Device type(s). The device type(s) identify the circuit function as follows:

Device type	Generic number 1/	Circuit function
01	SDP1085	3.0 A, positive voltage regulator, adjustable, low dropout

1.2.3 Device class designator. This device class designator shall be a single letter identifying the product assurance level. All levels are defined by the requirements of MIL-PRF-38534 and require QML Certification as well as qualification (Class H, K, and E) or QML Listing (Class G and D). The product assurance levels are as follows:

Device class	Device performance documentation
K	Highest reliability class available. This level is intended for use in space applications.
H	Standard military quality class level. This level is intended for use in applications where non-space high reliability devices are required.
G	Reduced testing version of the standard military quality class. This level uses the Class H screening and In-Process Inspections with a possible limited temperature range, manufacturer specified incoming flow, and the manufacturer guarantees (but may not test) periodic and conformance inspections (Group A, B, C and D).
E	Designates devices which are based upon one of the other classes (K, H, or G) with exception(s) taken to the requirements of that class. These exception(s) must be specified in the device acquisition document; therefore the acquisition document should be reviewed to ensure that the exception(s) taken will not adversely affect system performance.
D	Manufacturer specified quality class. Quality level is defined by the manufacturers internal, QML certified flow. This product may have a limited temperature range.

1/ The SDP1085 is similar to the LT1085 and OM1850 listed on Standard Microcircuit Drawing 5962-88646.

1.2.4 Case outline(s). The case outline(s) are as designated in MIL-STD-1835 and as follows:

Outline letter	Descriptive designator	Terminals	Package style
N	See figure 1	3	Z-tab with nonisolated tab, (TO-257Z), with glass seal
T	See figure 1	3	Flange mount with nonisolated tab, (TO-257), with glass seal
U	See figure 1	3	Flange mount with isolated tab, (TO-257), with glass seal
Z	See figure 1	3	Z-tab with isolated tab, (TO-257Z), with glass seal

1.2.5 Lead finish. The lead finish shall be as specified in MIL-PRF-38534.

1.3 Absolute maximum ratings. 1/

Input to output voltage differential	35 V dc
Output current (I_{OUT})	3.0 A
Storage temperature range	-65°C to +150°C
Lead temperature (soldering, 10 seconds)	+300°C
Junction temperature (T_J)	+150°C
Power dissipation (P_D)	Internally limited
Thermal resistance junction-to-case (q_{JC}):	
Case N and T	3.5°C/W
Case U and Z	4.2°C/W
Thermal resistance junction-to-ambient(q_{JA})	42°C/W

1.4 Recommended operating conditions.

Input to output voltage differential	25 V dc
Output current (I_{OUT})	10 mA to 2.0 A
Ambient operating temperature range (T_A)	-55°C to +125°C

2. APPLICABLE DOCUMENTS

2.1 Government specification, standards, and handbooks. The following specification, standards, and handbooks form a part of this drawing to the extent specified herein. Unless otherwise specified, the issues of these documents are those cited in the solicitation or contract.

DEPARTMENT OF DEFENSE SPECIFICATION

MIL-PRF-38534 - Hybrid Microcircuits, General Specification for.

DEPARTMENT OF DEFENSE STANDARDS

MIL-STD-883 - Test Method Standard Microcircuits.
MIL-STD-1835 - Interface Standard for Electronic Component Case Outlines.

1/ Stresses above the absolute maximum ratings may cause permanent damage to the device. Extended operation at the maximum levels may degrade performance and affect reliability.

DEPARTMENT OF DEFENSE HANDBOOKS

MIL-HDBK-103 - List of Standard Microcircuit Drawings.
MIL-HDBK-780 - Standard Microcircuit Drawings.

(Copies of these documents are available online at https://assist.daps.dla.mil/quicksearch/ or from the Standardization Document Order Desk, 700 Robbins Avenue, Building 4D, Philadelphia, PA 19111-5094.)

2.2 Order of precedence. In the event of a conflict between the text of this drawing and the references cited herein, the text of this drawing takes precedence. Nothing in this document, however, supersedes applicable laws and regulations unless a specific exemption has been obtained.

3. REQUIREMENTS

3.1 Item requirements. The individual item performance requirements for device classes D, E, G, H, and K shall be in accordance with MIL-PRF-38534. Compliance with MIL-PRF-38534 shall include the performance of all tests herein or as designated in the device manufacturer's Quality Management (QM) plan or as designated for the applicable device class. The manufacturer may eliminate, modify or optimize the tests and inspections herein, however the performance requirements as defined in MIL-PRF-38534 shall be met for the applicable device class. In addition, the modification in the QM plan shall not affect the form, fit, or function of the device for the applicable device class.

3.2 Design, construction, and physical dimensions. The design, construction, and physical dimensions shall be as specified in MIL-PRF-38534 and herein.

3.2.1 Case outline(s). The case outline(s) shall be in accordance with 1.2.4 herein and figure 1.

3.2.2 Terminal connections. The terminal connections shall be as specified on figure 2.

3.3 Electrical performance characteristics. Unless otherwise specified herein, the electrical performance characteristics are as specified in table I and shall apply over the full specified operating temperature range.

3.4 Electrical test requirements. The electrical test requirements shall be the subgroups specified in table II. The electrical tests for each subgroup are defined in table I.

3.5 Marking of device(s). Marking of device(s) shall be in accordance with MIL-PRF-38534. The device shall be marked with the PIN listed in 1.2 herein. In addition, the manufacturer's vendor similar PIN may also be marked.

3.6 Data. In addition to the general performance requirements of MIL-PRF-38534, the manufacturer of the device described herein shall maintain the electrical test data (variables format) from the initial quality conformance inspection group A lot sample, for each device type listed herein. Also, the data should include a summary of all parameters manually tested, and for those which, if any, are guaranteed. This data shall be maintained under document revision level control by the manufacturer and be made available to the preparing activity (DLA Land and Maritime -VA) upon request.

3.7 Certificate of compliance. A certificate of compliance shall be required from a manufacturer in order to supply to this drawing. The certificate of compliance (original copy) submitted to DLA Land and Maritime -VA shall affirm that the manufacturer's product meets the performance requirements of MIL-PRF-38534 and herein.

3.8 Certificate of conformance. A certificate of conformance as required in MIL-PRF-38534 shall be provided with each lot of microcircuits delivered to this drawing.

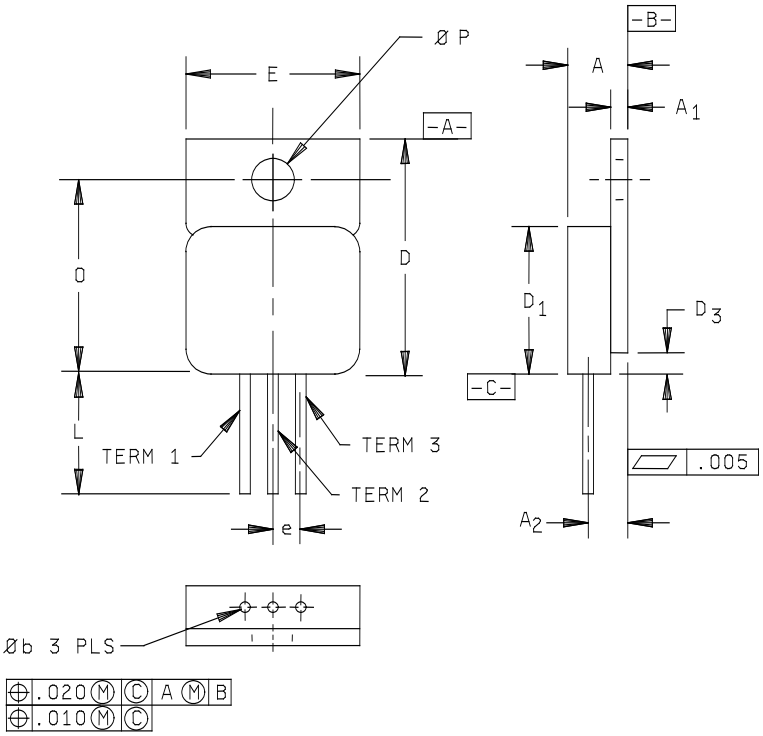
TABLE I. Electrical performance characteristics.

Test	Symbol	Conditions $-55°C \le T_A \le +125°C$ unless otherwise specified	Group A subgroups	Device type	Limits		Unit
					Min	Max	
Reference voltage	V_{REF}	$(V_{IN} - V_{OUT}) = 3.0$ V, $I_{OUT} = 10$ mA	1	01	1.238	1.262	V
		1.5 V $\le (V_{IN} - V_{OUT}) \le$ 25 V, 10 mA $\le I_{OUT} \le$ 2.0 A	1,2,3		1.220	1.270	
Line regulation 1/	$\frac{\Delta V_{OUT}}{\Delta V_{IN}}$	1.5 V $\le (V_{IN} - V_{OUT}) \le$ 15 V, $I_{OUT} = 10$ mA	1	01		0.2	%
		1.5 V $\le (V_{IN} - V_{OUT}) \le$ 35 V, $I_{OUT} = 10$ mA	2,3			0.5	
Load regulation 1/	$\frac{\Delta V_{OUT}}{\Delta I_{OUT}}$	$(V_{IN} - V_{OUT}) = 3.0$ V, 10 mA $\le I_{OUT} \le$ 2.0 A	1	01		0.8	%
			2,3			1.0	
Dropout voltage	V_{DO}	$I_{OUT} = 2.0$ A, $\Delta V_{REF} = 1.0\%$	1,2,3	01		1.5	V
Thermal regulation	- - -	30 ms pulse, $T_A = +25°C$	1	01		0.02	%/W
Ripple rejection	$\frac{\Delta V_{IN}}{\Delta V_{OUT}}$	f = 120 Hz, $C_{ADJ} = 25$ µF, $C_{OUT} = 25$ µF (tantalum), $I_{OUT} = 2.0$ A, $(V_{IN} - V_{OUT}) = 3.0$ V	4,5,6	01	60		dB
Adjust pin current	I_{ADJ}	1.5 V $\le (V_{IN} - V_{OUT}) \le$ 25 V, 10 mA $\le I_{OUT} \le$ 2.0 A	1,2,3	01		120	µA
Adjust pin current change	ΔI_{ADJ}	1.5 V $\le (V_{IN} - V_{OUT}) \le$ 25 V, 10 mA $\le I_{OUT} \le$ 2.0 A, $T_A = +25°C$	1	01		5.0	µA
Minimum load current	I_{MIN}	$(V_{IN} - V_{OUT}) = 25$ V	1,2,3	01		10	mA
Current limit	I_{LIM}	$(V_{IN} - V_{OUT}) = 5$ V	1,2,3	01	3.2		A
		$(V_{IN} - V_{OUT}) = 25$ V			0.2		
Temperature stability 2/	ΔV_{OUT}	$-55°C \le T_J \le +125°C$	1,2,3	01		1.5	%
Long term stability 2/	ΔV_{OUT}	t =1000 hrs, $T_A = +125°C$	2	01		1.0	%

1/ Line and load regulation are measured at a constant junction temperature using a low duty cycle pulse technique. Although power dissipation is internally limited, regulation is guaranteed up to the maximum power dissipation of 30 W. Power dissipation is determined by the input/output differential voltage and the output current. Guaranteed maximum power dissipation will not be available over the full input/output voltage range.

2/ If not tested, shall be guaranteed to the limits specified in table I.

Case outlines T and U.

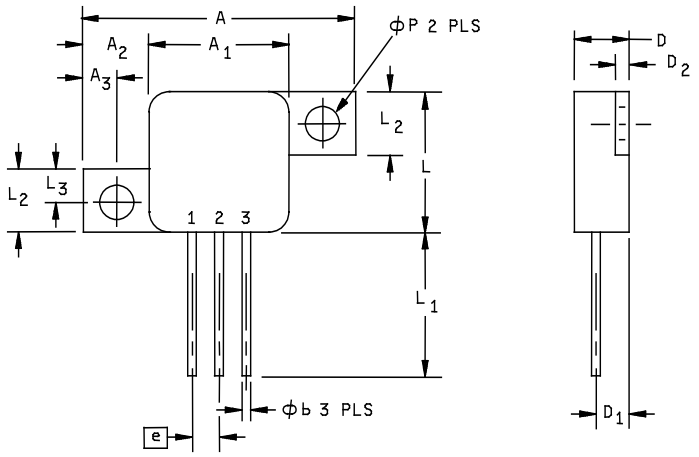


Symbol	Millimeters		Inches	
	Min	Max	Min	Max
A	4.83	5.08	.190	.200
A1	0.89	1.14	.035	.045
A2	3.05 BSC		.120 BSC	
øb	0.64	1.02	.025	.040
D	16.38	16.89	.645	.665
D1	10.41	10.92	.410	.430
D3	0.00	0.97	.000	.038
e	2.54 BSC		.100 BSC	
E	10.41	10.67	.410	.420
L	12.70	19.05	.500	.750
O	13.39	13.64	.527	.537
øP	3.56	3.81	.140	.150

NOTE:
The U.S. government preferred system of measurement is the metric SI system. However, this item was originally designed using inch-pound units of measurement. In the event of conflict between the metric and inch-pound units, the inch-pound units shall take precedence.

FIGURE 1. Case outline(s).

Case outlines N and Z.

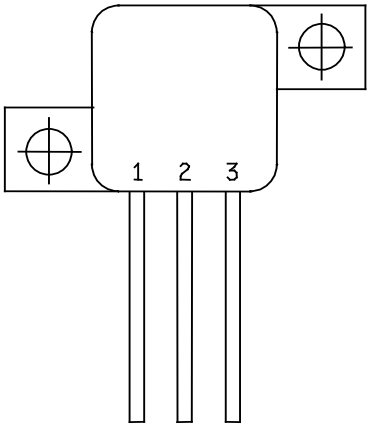


Symbol	Millimeters		Inches	
	Min	Max	Min	Max
A	23.11	23.37	.910	.920
A1	10.41	10.67	.410	.420
A2	6.22	6.48	.245	.255
A3	3.05	3.30	.120	.130
øb	0.71	0.81	.028	.032
D	4.70	5.59	.135	.220
D1	2.92	3.18	.115	.125
D2	0.89	1.14	.035	.045
e	2.54 BSC		.100 BSC	
L	10.41	10.67	.410	.420
L1	12.70	19.05	.500	.750
L2	6.22	6.48	.245	.255
L3	3.05	3.30	.120	.130
øP	3.05	3.30	.120	.130

NOTE:
The U.S. government preferred system of measurement is the metric SI system. However, this item was originally designed using inch-pound units of measurement. In the event of conflict between the metric and inch-pound units, the inch-pound units shall take precedence.

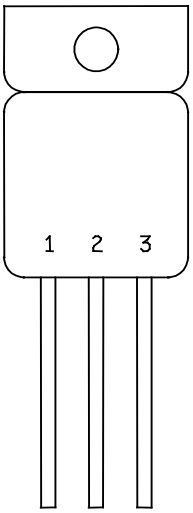
FIGURE 1. Case outline(s) - Continued.

Case outlines N and Z



Top view

Case outlines T and U



Top view

Device type	01	
Case outlines	N and T (nonisolated tab)	U and Z (isolated tab)
Terminal number	Terminal symbol	Terminal symbol
1 2 3 Tab	Adjust No connection Input Output	Adjust Output Input No connection

FIGURE 2. Terminal connections.

TABLE II. Electrical test requirements.

MIL-PRF-38534 test requirements	Subgroups (in accordance with MIL-PRF-38534, group A test table)
Interim electrical parameters	1
Final electrical parameters	1*, 2, 3, 4, 5, 6
Group A test requirements	1, 2, 3, 4, 5, 6
Group C end-point electrical parameters	1, 2, 3
End-point electrical parameters for Radiation Hardness Assurance (RHA) devices	Not applicable

* PDA applies to subgroup 1.

4. VERIFICATION

4.1 Sampling and inspection. Sampling and inspection procedures shall be in accordance with MIL-PRF-38534 or as modified in the device manufacturer's Quality Management (QM) plan. The modification in the QM plan shall not affect the form, fit, or function as described herein.

4.2 Screening. Screening shall be in accordance with MIL-PRF-38534. The following additional criteria shall apply:

a. Burn-in test, method 1015 of MIL-STD-883.

(1) Test condition A, B, C, or D. The test circuit shall be maintained by the manufacturer under document revision level control and shall be made available to either DLA Land and Maritime -VA or the acquiring activity upon request. Also, the test circuit shall specify the inputs, outputs, biases, and power dissipation, as applicable, in accordance with the intent specified in method 1015 of MIL-STD-883.

(2) T_A as specified in accordance with table I of method 1015 of MIL-STD-883.

b. Interim and final electrical test parameters shall be as specified in table II herein, except interim electrical parameter tests prior to burn-in are optional at the discretion of the manufacturer.

4.3 Conformance and periodic inspections. Conformance inspection (CI) and periodic inspection (PI) shall be in accordance with MIL-PRF-38534 and as specified herein.

4.3.1 Group A inspection (CI). Group A inspection shall be in accordance with MIL-PRF-38534 and as follows:

a. Tests shall be as specified in table II herein.

b. Subgroups 7, 8, 9, 10, and 11 shall be omitted.

4.3.2 Group B inspection (PI). Group B inspection shall be in accordance with MIL-PRF-38534.

4.3.3 Group C inspection (PI). Group C inspection shall be in accordance with MIL-PRF-38534 and as follows:

a. End-point electrical parameters shall be as specified in table II herein.

b. Steady-state life test, method 1005 of MIL-STD-883.

(1) Test condition A, B, C, or D. The test circuit shall be maintained by the manufacturer under document revision level control and shall be made available to either DLA Land and Maritime -VA or the acquiring activity upon request. Also, the test circuit shall specify the inputs, outputs, biases, and power dissipation, as applicable, in accordance with the intent specified in method 1005 of MIL-STD-883.

(2) T_A as specified in accordance with table I of method 1005 of MIL-STD-883.

(3) Test duration: 1,000 hours, except as permitted by method 1005 of MIL-STD-883.

4.3.4 Group D inspection (PI). Group D inspection shall be in accordance with MIL-PRF-38534.

4.3.5 Radiation Hardness Assurance (RHA) inspection. RHA inspection is not currently applicable to this drawing.

5. PACKAGING

5.1 Packaging requirements. The requirements for packaging shall be in accordance with MIL-PRF-38534.

6. NOTES

6.1 Intended use. Microcircuits conforming to this drawing are intended for use for Government microcircuit applications (original equipment), design applications, and logistics purposes.

6.2 Replaceability. Microcircuits covered by this drawing will replace the same generic device covered by a contractor-prepared specification or drawing.

6.3 Configuration control of SMD's. All proposed changes to existing SMD's will be coordinated as specified in MIL-PRF-38534.

6.4 Record of users. Military and industrial users shall inform DLA Land and Maritime when a system application requires configuration control and the applicable SMD to that system. DLA Land and Maritime will maintain a record of users and this list will be used for coordination and distribution of changes to the drawings. Users of drawings covering microelectronic devices (FSC 5962) should contact DLA Land and Maritime-VA, telephone (614) 692-0547.

6.5 Comments. Comments on this drawing should be directed to DLA Land and Maritime-VA, Columbus, Ohio 43218-3990, or telephone (614) 692-1081.

6.6 Sources of supply. Sources of supply are listed in MIL-HDBK-103 and QML-38534. The vendors listed in MIL-HDBK-103 and QML-38534 have submitted a certificate of compliance (see 3.7 herein) to DLA Land and Maritime-VA and have agreed to this drawing.

STANDARD MICROCIRCUIT DRAWING BULLETIN

DATE: 12-05-15

Approved sources of supply for SMD 5962-98649 are listed below for immediate acquisition information only and shall be added to MIL-HDBK-103 and QML-38534 during the next revisions. MIL-HDBK-103 and QML-38534 will be revised to include the addition or deletion of sources. The vendors listed below have agreed to this drawing and a certificate of compliance has been submitted to and accepted by DLA Land and Maritime -VA. This information bulletin is superseded by the next dated revisions of MIL-HDBK-103 and QML-38534. DLA Land and Maritime maintains an online database of all current sources of supply at http://www.landandmaritime.dla.mil/Programs/Smcr/.

Standard microcircuit drawing PIN 1/ 2/	Vendor CAGE number	Vendor similar PIN 3/
5962-9864901HNA	21845	SDP1085NHD
5962-9864901HNC	21845	SDP1085NHG
5962-9864901HTA	21845	SDP1085THD
5962-9864901HTC	21845	SDP1085THG
5962-9864901HUA	21845	SDP1085UHD
5962-9864901HUC	21845	SDP1085UHG
5962-9864901HZA	21845	SDP1085ZHD
5962-9864901HZC	21845	SDP1085ZHG

1/ The lead finish shown for each PIN representing a hermetic package is the most readily available from the manufacturer listed for that part. If the desired lead finish is not listed contact the Vendor to determine its availability.
2/ The SMD device types listed above are similar to the device types listed on SMD 5962-88646. 5962-9864901HUA or C is similar to 5962-8864601UX.
3/ Caution. Do not use this number for item acquisition. Items acquired to this number may not satisfy the performance requirements of this drawing.

Vendor CAGE number	Vendor name and address
21845	Solitron Devices, Incorporated 3301 Electronics Way West Palm Beach, FL 33407